


<b>Search Notes</b>  	<b>Application/Control No.</b>  10542719	<b>Applicant(s)/Patent Under Reexamination</b>  HOFER, GUNTER
	<b>Examiner</b>  Johnson, Ryan J	<b>Art Unit</b>  2817

SEARCHED			
Class	Subclass	Date	Examiner
331	106,117R,116R,116FE,158,167,177R,182,183,185	7/3/2007	Ryan Johnson
327	156,157	7/3/2007	Ryan Johnson
332	100	7/3/2007	Ryan Johnson
375	303,334	7/3/2007	Ryan Johnson
331	106,117R,116R,116FE,158,167,177R,182,183,185	12/14/2007	Ryan Johnson
327	156,157	12/14/2007	Ryan Johnson
332	100	12/14/2007	Ryan Johnson
375	303,334	12/14/2007	Ryan Johnson

SEARCH NOTES		
Search Notes	Date	Examiner
See EAST history	7/3/2007	Ryan Johnson
Emailed Joseph Chang	7/3/2007	Ryan Johnson
See EAST history	12/14/2007	Ryan Johnson
Emailed Joseph Chang	12/14/2007	Ryan Johnson
IEEE search	12/14/2007	Ryan Johnson

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	See EAST history	12/14/2007	Ryan Johnson